

TO:

文件编号

HXA-L31-23(01)

发行日期

2017年11月15日

承认规格书

种类: Power Inductor

系列号: HXNR4020B-1R5M

客户料号:

客户承认栏

客户承认栏	
承认日期	年 月 日

(贵司承认后请签署一份返回华信安电子, 谢谢!)

厦门华信安电子科技有限公司技术质量部

承认	确认	作成
龙梅	梁峰	王亮

TEL: 0592-6301603 FAX: 0592-5205265

Http: www.xmisnd.com

Power Inductor**HXNR4020B-1R5M****ECN HISTORY LIST**

REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN
1.0	17/11/15	新發行	龙梅	梁峰	王亮
備註					

Power Inductor

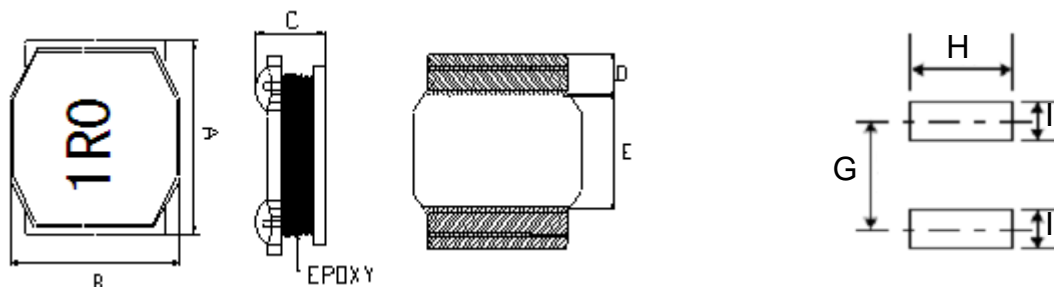
HXNR4020B-1R5M

1. Features

1. This specification applies Low Profile Power Inductors.
2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.



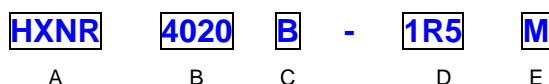
2. Dimension



Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	G(mm)	H(mm)	I(mm)
HXNR4020B	4.0±0.2	4.0±0.2	2.0 max.	1.2ref.	1.8ref.	2.8 ref.	3.7 ref.	1.2 ref.

Units: mm

3. Part Numbering



A: Series

B: Dimension

C: Control S/N

D: Inductance

1R5=1.5uH

E: Inductance Tolerance

M=±20%;

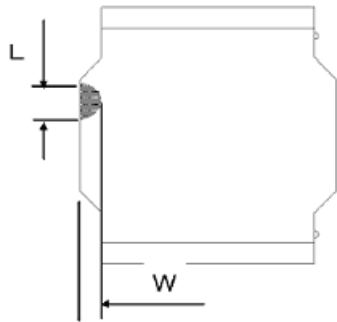
4. Specification

ISND Part Number	Inductance (uH)	Tolerance (%)	Test Frequency (Hz)	DCR (Ω) ±30%	I sat (A)	I rms (A)
HXNR4020B-1R5M	1.5	±20%	0.25V100K	0.03	3.85	2.15

Note:

Isat: Based on inductance change ($\Delta L/L0: \leq -30\%$) @ ambient temp. 25°CIrms: Based on temperature rise ($\Delta T: 40^\circ\text{C typ.}$)

Core chipping

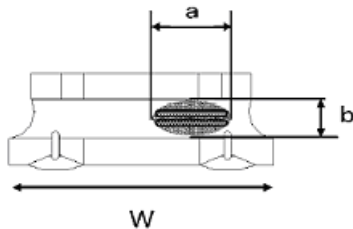


Type	L	W
HXNR4020B	1.5mm Max.	1.5mm Max.

Void appearance tolerance Limit

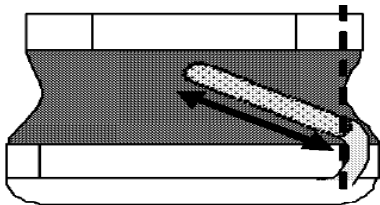
Size of voids occurring to coating resin is specified below.

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.



External appearance criterion for exposed wire

Exposed end of the winding wire at the secondary side should be 2mm and below.

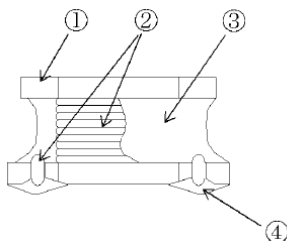


Exposed wire tolerance limit of coating resin part on product side.

Size of exposed wire occurring to coating resin is specified below.

1. Width direction (dimension a) : Acceptable when $a \leq w/2$
Nonconforming when $a > w/2$
2. Length direction (dimension b) : Dimension b is not specified.
3. When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

5. Material List



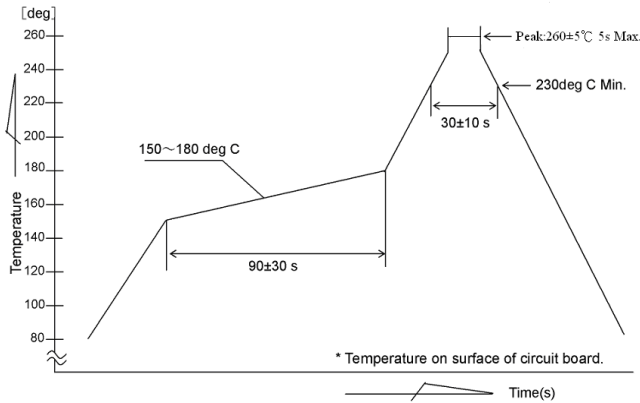
No.	Item	Material
1	Core	Ni-Zn ferrite
2	Wire	Copper Wire
3	Coating	Epoxy
4	Solder	Lead free

6. Reliability and Test Condition

Item	Performance	Test Method and Remarks
Operating Temperature	- 25 ~ +125°C.	Including self-generated heat
Storage Temperature	-40 ~ +85°C. - 5 to 40°C for the product with taping.	
Rated current	Within the specified tolerance	
Inductance (L)		LCR Meter: HP 4285A or equivalent, 100kHz, 1V
DC Resistance		DC Ohmmeter: HIOKI3227 or equivalent
Temperature characteristics	Inductance change: Within±20%	Measurement of inductance shall be taken at temperature rang within-25°C to +85°C. With reference to inductance value at+20 °C,change rate shall be calculated. Measurement of inductance shall be taken at temperature rang within-40°C to +125°C. With reference to inductance value at+20 °C,change rate shall be calculated.
Resistance to flexure substrate	No damage.	The test samples shall be soldered to the testing board by the reflow. As illustrated below, apply force in the direction of the arrow indicating until deflection of the test board reaches to 2mm. Substrate size: 100x40x1.0 Substrate material: glass epoxy-resin Solder cream thickness: 0.15
Adhesion of Terminal electrode	Shall not come off PC board.	The test samples shall be soldered to the testing board and by the reflow. Applied force: 10 N to X and Y directions. Duration: 5s Solder cream thickness: 0.15
Resistance to Vibration	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. Then it shall be submitted to below test conditions. Frequency: 10-55Hz Total Amplitude: 1.5mm (May not exceed acceleration 196m/S2) Sweeping Method:10Hz to 55Hz to 10Hz for 1min. Time: 2 hours each in X,Y, and Z Direction. Recovery: At least 2hrs of recovery under the standard condition after the test, followed by the measurement within 48hrs.
Solderability	At least 90% of surface of terminal electrode is covered by new solder.	The test samples shall be dipped in flux, and then immersed in molten solder as shown in below. Flux: methanol solution containing rosin 25% Solder temperature: 245±5°C Time: 5±1.0 sec. Immersion depth: All sides of mounting terminal shall be immersed.
Resistance to soldering	Inductance change: Within±10% No abnormality observed in appearance.	The test sample shall be exposed to reflow oven at 230±5°C for 40 seconds, with peak temperature at 260±5°C for 5 seconds,2 times. Test board thickness: 1.0mm Test board material: glass epoxy-resin

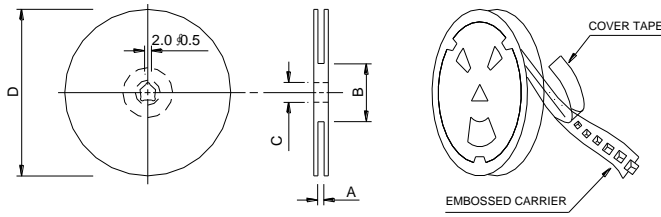
Item	Performance	Test Method and Remarks															
Thermal shock		The test samples shall be soldered to the test board by the reflow. The test samples shall be placed at specified temperature for specified time by step 1 to step 4 as shown below in sequence. The temperature cycles shall be repeated 100 cycles . <table border="1" data-bbox="991 309 1374 427"> <thead> <tr> <th>Phase</th> <th>Temperature(°C)</th> <th>Time(min.)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>-40±3°C</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp</td> <td>Within 3</td> </tr> <tr> <td>3</td> <td>85±2°C</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp</td> <td>Within 3</td> </tr> </tbody> </table>	Phase	Temperature(°C)	Time(min.)	1	-40±3°C	30±3	2	Room Temp	Within 3	3	85±2°C	30±3	4	Room Temp	Within 3
Phase	Temperature(°C)	Time(min.)															
1	-40±3°C	30±3															
2	Room Temp	Within 3															
3	85±2°C	30±3															
4	Room Temp	Within 3															
Damp heat life test		Test Method and Remarks The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below. Temperature: 60±2°C Humidity: 90~95%RH Time: 500+24/-0 hrs															
Loading under damp heat life test	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below. Temperature: 60±2°C Humidity: 90~95%RH Applied current: Rated current Time: 500+24/-0 hrs															
Low temperature life test		The test samples shall be soldered to the test board by the reflow. After that, the test samples shall be placed at test conditions as shown in below. Temperature: -40±2°C Time: 500+24/-0 hrs															
Loading at high temperature life test		The test samples shall be soldered to the test board by the reflow. Temperature: 85±2°C. Applied current: Rated current Time: 500+24/-0 hrs.															

7. Soldering



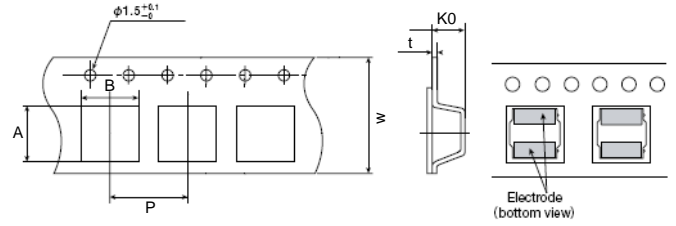
8. Packaging Information

(1) Reel Dimension



Type	A(mm)	B(mm)	C(mm)	D(mm)
HXNR4020B	12.4±2.0	100±4.0	13.2±0.2	330±2.0

(2) Tape Dimension



Type	A0(mm)	B0(mm)	K0(mm)	P(mm)	W(mm)	t(mm)
HXNR4020B	4.25±0.1	4.25±0.1	2.3±0.1	8.0±0.1	12.0±0.3	0.3±0.05

(3) Packaging Quantity

Type	Chip / Reel
HXNR4020B	3000

Application Notice

- Storage Conditions
To maintain the solderability of terminal electrodes:
 1. ISND products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
 2. Temperature and humidity conditions: Less than 40°C and 60% RH.
 3. Recommended products should be used within 12 months from the time of delivery.
 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

单击下面可查看定价，库存，交付和生命周期等信息

[>>ISND\(华信安\)](#)

[>>点击查看相关商品](#)